

OptiMOS[™] Power-Transistor

Features

- · Optimized for synchronous rectification
- 100% avalanche tested
- Superior thermal resistance
- N-channel, normal level
- Qualified according to JEDEC¹⁾ for target applications
- · Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21



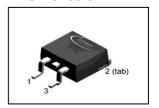


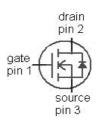


Product Summary

V _{DS}	60	V
$R_{\mathrm{DS(on),max}}$	2.6	mΩ
I _D	100	Α
Q _{oss}	65	nC
Q _g (0V10V)	56	nC

PG-TO263-3





Туре	Package	Marking
IPB026N06N	PG-TO263-3	026N06N

Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	V _{GS} =10 V, T _C =25 °C	100	А
		V _{GS} =10 V, T _C =100 °C	100	
		$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C, $R_{\rm thJA}$ =50K/W	25	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25 °C	400	
Avalanche energy, single pulse ³⁾	E _{AS}	$I_{\rm D}$ =100 A, $R_{\rm GS}$ =25 Ω	110	mJ
Gate source voltage	V_{GS}		±20	V

¹⁾ J-STD20 and JESD22

²⁾ See figure 3 for more detailed information

³⁾ See figure 13 for more detailed information

⁴⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.



Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Power dissipation	P_{tot}	T _C =25 °C	136	W
		T _A =25 °C, R _{thJA} =50 K/W	3.0	
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

Parameter	Symbol	Conditions	Values U		Unit	
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R_{thJC}	bottom	-	-	1.1	K/W
Device on PCB	R_{thJA}	minimal footprint			62	
		6 cm² cooling area ⁴⁾	-	-	40	

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$ V_{GS} =0 V, I_D =1 mA		60	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS}=V_{\rm GS}, I_{\rm D}=75~\mu{\rm A}$	2.1	2.8	3.3	
Zero gate voltage drain current	I _{DSS}	$V_{\rm DS}$ =60 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C	1	0.5	1	μA
		V _{DS} =60 V, V _{GS} =0 V, T _j =125 °C	-	10	100	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	10	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _D =100 A	-	2.3	2.6	mΩ
		V _{GS} =6 V, I _D =25 A	-	3.0	3.9	
Gate resistance	R _G		-	1.3	1.95	Ω
Transconductance	g_{fs}	V _{DS} >2 I _D R _{DS(on)max} , I _D =100 A	80	160	-	s



Parameter	Symbol	Conditions		Values		Unit	
			min.	typ.	max.		
Dynamic characteristics							
Input capacitance	Ciss		-	4100	5125	pF	
Output capacitance	Coss	$V_{\rm GS}$ =0 V, $V_{\rm DS}$ =30 V, f =1 MHz	-	980	1225		
Reverse transfer capacitance	C _{rss}		-	39	78		
Turn-on delay time	t _{d(on)}		-	17	-	ns	
Rise time	t _r	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A,	-	15	-		
Turn-off delay time	t _{d(off)}	$R_{G,ext}$, ext=3 Ω	-	30	-		
Fall time	t _f		-	8	-	7	
Gate Charge Characteristics ⁵⁾							
Gate to source charge	Q _{gs}		1	20	-	nC	
Gate charge at threshold	Q _{g(th)}		-	11	-		
Gate to drain charge	Q _{gd}	V _{DD} =30 V, I _D =100 A,	-	11	15		
Switching charge	Q _{sw}	V _{GS} =0 to 10 V	1	19	-		
Gate charge total	Qg		-	56	66		
Gate plateau voltage	V _{plateau}		-	4.8	-	V	
Gate charge total, sync. FET	Q _{g(sync)}	V _{DS} =0.1 V, V _{GS} =0 to 10 V	-	49	-	nC	
Output charge	Q _{oss}	V _{DD} =30 V, V _{GS} =0 V	-	65	-	1	
Reverse Diode	•					•	
Diode continuous forward current	Is	- T _C =25 °C	-	-	100	А	
Diode pulse current	I _{S,pulse}	7 C-23 C	-	-	400		
Diode forward voltage	V_{SD}	V _{GS} =0 V, I _F =100 A, T _j =25 °C	-	1.0	1.2	V	
Reverse recovery time	t _{rr}	V _R =30 V, I _F =100 A,	-	55	88	ns	
Reverse recovery charge	Q _{rr}	d <i>i_F</i> /d <i>t</i> =100 A/μs	-	73	-	nC	

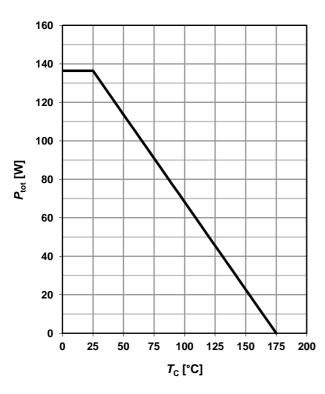
 $^{^{\}rm 5)}$ See figure 16 for gate charge parameter definition

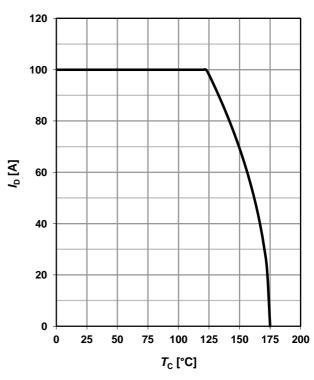


1 Power dissipation

$P_{\text{tot}} = f(T_{\text{C}})$

2 Drain current





3 Safe operating area

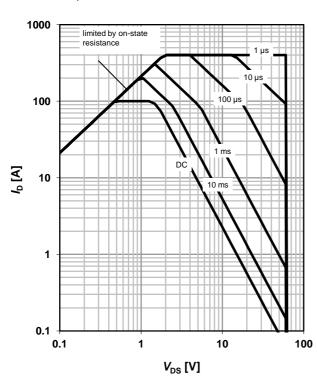
 $I_D=f(V_{DS}); T_C=25 \text{ °C}; D=0$

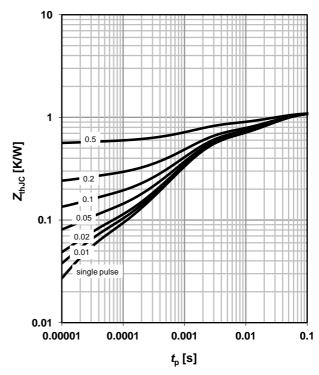
parameter: t_p

4 Max. transient thermal impedance

 $Z_{\text{thJC}} = f(t_p)$

parameter: $D=t_p/T$



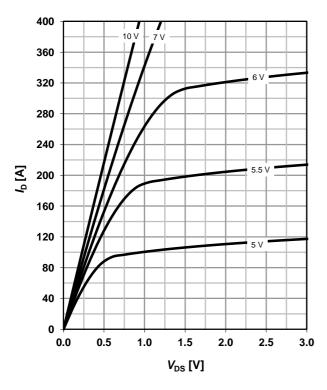




5 Typ. output characteristics

 $I_D=f(V_{DS}); T_j=25 \text{ °C}$

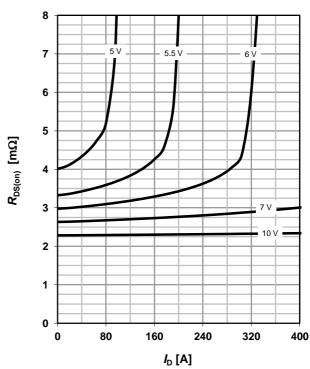
parameter: V_{GS}



6 Typ. drain-source on resistance

 $R_{DS(on)}=f(I_D); T_j=25 °C$

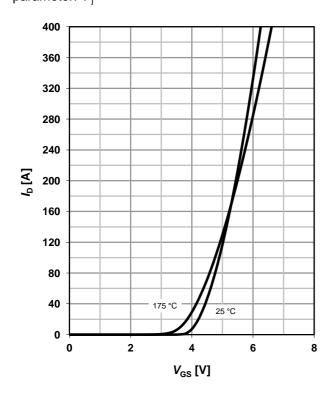
parameter: V_{GS}



7 Typ. transfer characteristics

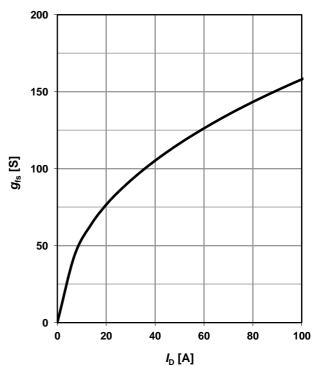
 $I_{D}=f(V_{GS}); |V_{DS}|>2|I_{D}|R_{DS(on)max}$

parameter: T_i



8 Typ. forward transconductance

 $g_{fs}=f(I_D); T_j=25 \text{ °C}$



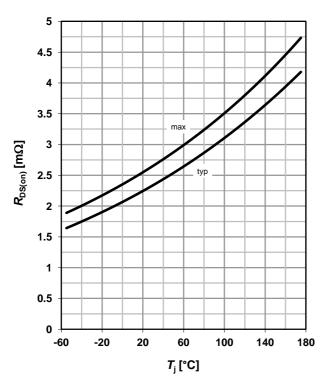


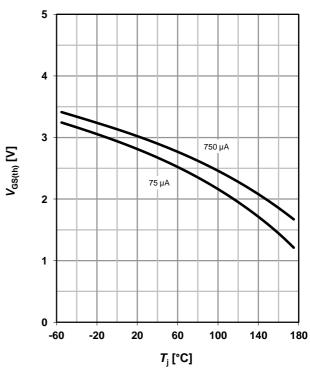
9 Drain-source on-state resistance

$R_{DS(on)} = f(T_i); I_D = 100 \text{ A}; V_{GS} = 10 \text{ V}$

10 Typ. gate threshold voltage

$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$$





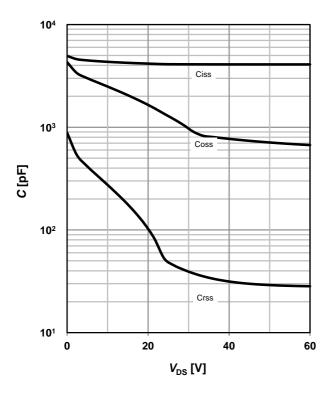
11 Typ. capacitances

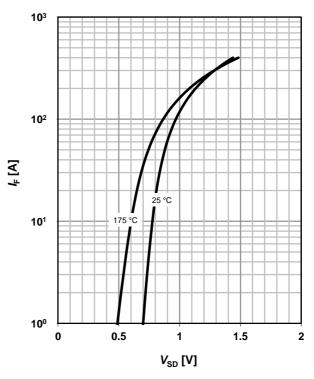
$$C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$$

12 Forward characteristics of reverse diode

 $I_F = f(V_{SD})$

parameter: T_i







13 Avalanche characteristics

 $I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

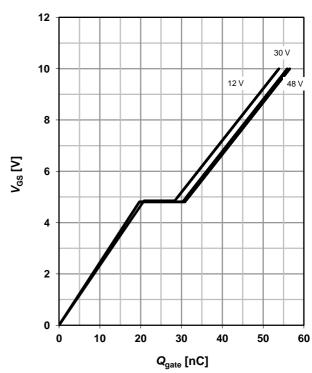
parameter: $T_{j(start)}$

1000 100°C 100°C 125°C 25°C 25°C 1000°C

14 Typ. gate charge

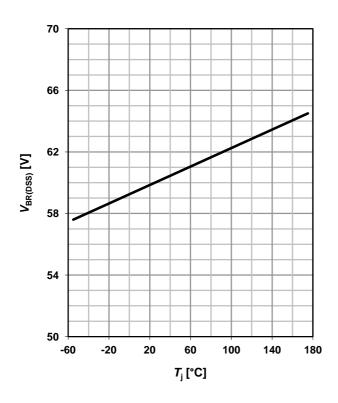
 V_{GS} =f(Q_{gate}); I_D =100 A pulsed

parameter: $V_{\rm DD}$

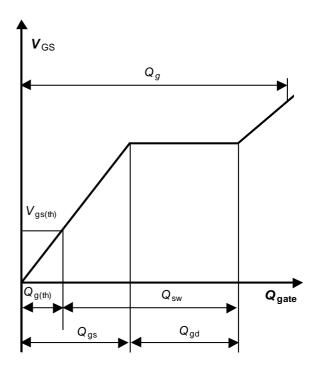


15 Drain-source breakdown voltage

 $V_{BR(DSS)}=f(T_j); I_D=1 \text{ mA}$



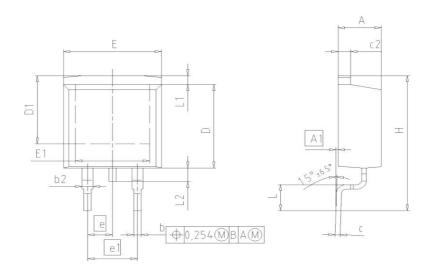
16 Gate charge waveforms

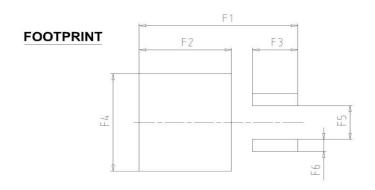




Package Outline

PG-TO263-3





DIM	MILLIM	ETERS	INCI	HES	
DIM	MIN	MAX	MIN	MAX	
Α	4.30	4.57	0.169	0.180	
A1	0.00	0.25	0.000	0.010	
b	0.65	0.85	0.026	0.033	
b2	0.95	1.15	0.037	0.045	
С	0.33	0.65	0.013	0.026	
c2	1.17	1.40	0.046	0.055	
D	8.51	9.45	0.335	0.372	
D1	7.10	7.90	0.280	0.311	
E	9.80	10.31	0.386	0.406	
E1	6.50	8.60	0.256	0.339	
е	2.5	2.54		0.100	
e1	5.0	08	0.200		
N		2		2	
Н	14.61	15.88	0.575	0.625	
L	2.29	3.00	0.090	0.118	
L1	0.70	1.60	0.028	0.063	
L2	1.00	1.78	0.039	0.070	
F1	16.05	16.25	0.632	0.640	
F2	9.30	9.50	0.366	0.374	
F3	4.50	4.70	0.177	0.185	
F4	10.70	10.90	0.421	0.429	
F5	3.65	3.85	0.144	0.152	
F6	1.25	1.45	0.049	0.057	

	ENT NO. 003324
SCALE	0
0	5 5 7.5mm
EUROPEAN	PROJECTION
ISSUE 30-08	
REV	ISION



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